



PRODUCT DATA SHEET



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Datasheet

Sample

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
30V	12m Ω	45A

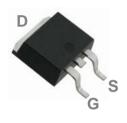
Features

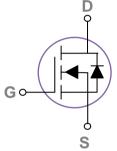
- 30V,45A, $RDS(ON) = 12m\Omega(Typ) @VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR







Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
1	Drain Current – Continuous (T _C =25°C)	45	А
lD	Drain Current – Continuous (T _C =100°C)	28	А
I _{DM}	Drain Current – Pulsed¹	180	А
EAS	Single Pulse Avalanche Energy ²	13	mJ
IAS	Single Pulse Avalanched Current ²	16	А
D	Power Dissipation (T _C =25°C)	33	W
P_{D}	Power Dissipation – Derate above 25°C	0.26	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Symbol Parameter		Max.	Unit	
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W	
$R_{\theta JC}$	Thermal Resistance Junction to Case		3.8	°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwisenoted)

Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA				V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.04		V/°C
I _{DSS}	Dunin Saurea Lankana Cumant	V_{DS} =30V , V_{GS} =0V , T_J =25°C			1	uA
	Drain-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

R _{DS(ON)} Stat	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =10A		9.4	12	mΩ
		V_{GS} =4.5V , I_D =5A		13	18	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA		1.8	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-4		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =3A		6.4		S

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{3, 4}		 7.4	12	
Q _{gs}	Gate-Source Charge ^{3,4}	V_{DS} =15V , V_{GS} =4.5V , I_{D} =5A	 2.3	5	nC
Q_{gd}	Gate-Drain Charge ^{3,4}		 3	6	
T _{d(on)}	Turn-On Delay Time ^{3,4}		 3.8	7	
Tr	Rise Time ^{3, 4}	V_{DD} =15 V , V_{GS} =10 V , R_{G} =6 Ω	 10	19	no
T _{d(off)}	Turn-Off Delay Time ^{3,4}	I _D =1A	 22	42	ns
T _f	Fall Time ^{3, 4}		 6.6	13	
C _{iss}	Input Capacitance		 620	900	
Coss	Output Capacitance V _{DS} =25V , V _{GS} =0V , F=1MHz		 85	125	pF
C _{rss}	Reverse Transfer Capacitance		 60	90	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	 2.8	5.6	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			45	Α
I _{SM}	Pulsed Source Current ³	VG=VD=OV, Force Current			180	Α
V _{SD}	Diode Forward Voltage ³	V_{GS} =0V , I_{S} =1A , T_{J} =25 $^{\circ}$ C			1	V
t _{rr}	Reverse Recovery Time	Vgs=0V,ls=1A , di/dt=100A/µs				ns
Q_{rr}	Reverse Recovery Charge	T _J =25°C				nC

- Repetitive Rating: Pulsed width limited by maximum junction temperature.
- V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =16A., R_{G} =25 Ω , Starting T_{J} =25 $^{\circ}$ C.
- The data tested by pulsed , pulse wiuiii ≥ 000000 ,
 Essentially independent of operating temperature. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.



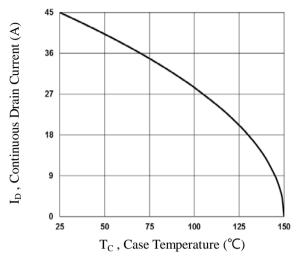


Fig.1 Continuous Drain Current vs. T_c

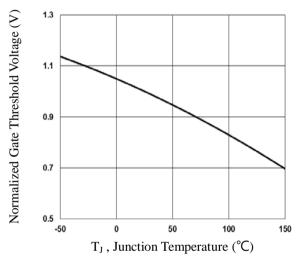


Fig.3 Normalized V_{th} vs. T_J

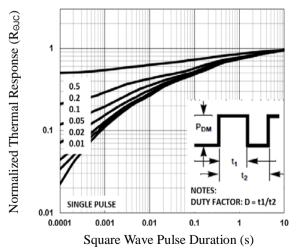


Fig.5 Normalized Transient Response

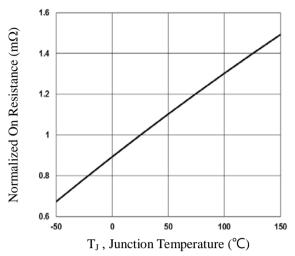


Fig.2 Normalized RDSON vs. T_J

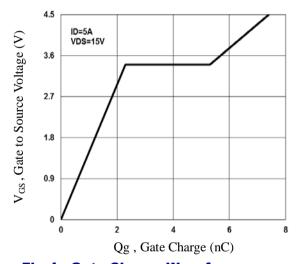


Fig.4 Gate Charge Waveform

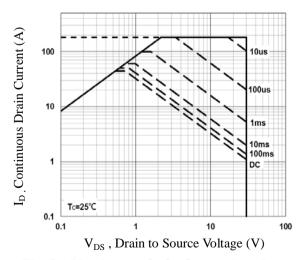
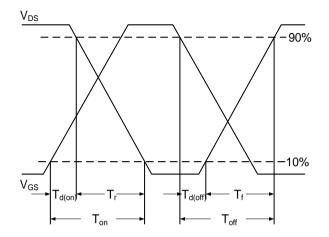


Fig.6 Maximum Safe Operation Area







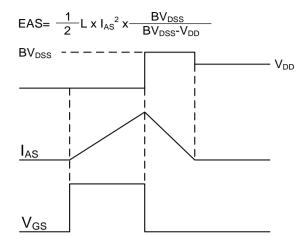
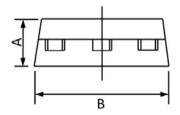


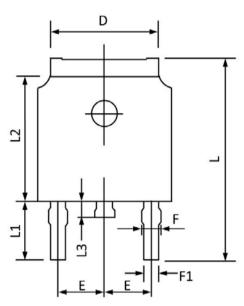
Fig.7 Switching Time Waveform

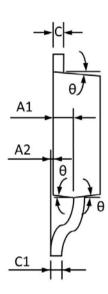
Fig.8 EAS Waveform



TO252 PACKAGE INFORMATION







Crussk ol	Dimensions In	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
A	2.20	2.40	0.087	0.094
A1	0.91	1.11	0.036	0.044
A2	0.00	0.15	0.000	0.006
В	6.50	6.70	0.256	0.264
С	0.46	0.580	0.018	0.230
C1	0.46	0.580	0.018	0.030
D	5.10	5.46	0.201	0.215
E	2.186	2.386	0.086	0.094
F	0.74	0.94	0.029	0.037
F1	0.660	0.860	0.026	0.034
L	9.80	10.40	0.386	0.409
L1	2.9R	REF	0.114	REF
L2	6.00	6.20	0.236	0.244
L3	0.60	1.00	0.024	0.039
θ	3°	9°	3°	9°



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